Article

Effects of Voltage Dips on Robotic Grasping

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Received: 18 February 2019; Accepted: 8 April 2019; Published: 11 April 2019

Abstract: This paper addresses the effects of electric power quality on robotic operations. A general overview is reported to highlight the main characteristics of electric power quality and it’s effects on a powered system by considering an end-user’s viewpoint. Then, the authors outline the influence of voltage dip effects by focusing on robotic grasping applications. A specific case study is reported, namely that of LARM Hand IV, a three-fingered robotic hand which has been designed and built at LARM in Cassino, Italy. A dedicated test rig has been developed and set up to generate predefined voltage dips. Experimental tests are carried out to evaluate the effects of different types of voltage dip on the grasping of objects.

Keywords: robotic hands; grasping; electric power quality; voltage dips effects

1. Introduction

Nowadays, electronic equipment and computing devices are used in most types of industrial machines and robotic devices. They are key systems for the successful implementation of most industrial processes. However, the wide use of electronics makes this equipment more vulnerable to disturbances in terms of power quality (PQ). PQ is related to several disturbances that include, among others, momentary interruptions, voltage dips or sags, swells, transients, harmonic distortion, electrical noise, and flickering lights [1]. In general, the electrical power grid is designed to deliver power reliably with the aim of maximizing the amount of power available to customers. However, PQ disturbances are not always taken into consideration despite the fact that they can significantly affect industrial production, as well as permanently damage expensive equipment, costing industrial plants millions of dollars [2]. In order to minimize these costs, it is critical for industrial customers to understand how PQ can affect the operation of their systems and how it is possible to mitigate the effects of PQ disturbances [1–3].

The international framework of the actual standards on PQ is based on the norms of the International Electro-technical Commission (IEC), which is accepted as a worldwide reference. Moreover, national or supranational committees give further indications on the maximum limits to be imposed on PQ disturbances. For example, the European Committee for Electrotechnical Standardization (CENELEC) is the European reference, while Comitato Elettrotecnico Italiano (CEI) is the Italian national reference for adopting IEC and CENELEC standards. The above-mentioned bodies have released the norm EN 50160 that defines the European and Italian standards for the PQ in terms of voltage dips and other voltage disturbances [4]. Similarly, the norms EN 61000-4-11 and EN 61000-4-34 are adopted worldwide [4–7].

PQ is gaining significance also in robotics, and specifically in applications of service robotics. Voltage dips, also defined by the equivalent term voltage sags, are recognized as one of the most severe
disturbances that can affect the operation of industrial devices. The detrimental effects of voltage dips can result both in the tripping of the protective devices with the equipment shut down and in the malfunction of a device. The latter constitutes a sort of failure that determines a far from normal or satisfactory functionality. Both these typologies of effects have significant economic impacts on a system’s operation and productivity. These costs depend on many factors that are linked to the type of manufacturing activity and to the extent of the affected area [3].

Among other industrial devices, robots certainly suffer for the presence of voltage dips in the supply voltage. This is particularly critical in the case of collaborative robots which are penetrating several new applications also thanks to the publication of a collaborative robotics reference standard [8]. In fact, the recent ISO (International Organization for Standardization) norm establishes a novel regulatory framework allowing a wide spread of collaborative robots in industrial and civil environments. The close interaction among robots and humans makes safety one of the most significant aspects of robot design and operation. Clearly, the effects of the voltage dips in the supply voltage can significantly influence robot performance as well as generate potentially critical safety issues, such as missing operations or unpredictable robot behaviors.

The case of robot grasping is quite significant, since the performance of an end-effector is considered to be the most important contribution to achieving the successful manipulation of an object. Several researchers have addressed the design of grasping devices with solutions ranging from simple end-effectors (suction cups, electromagnetic devices) to finger grippers for handling specific objects, and even complex multi-purpose robotic hands [9–13]. It appears very significant to investigate the effects of power quality on a robot grasping, since a grasping failure implies a failure of the whole robotic manipulation procedure. Moreover, this can have strong safety implications, especially in collaborative robotics tasks, as mentioned in [8].

This paper addresses the effects of the voltage dips on the performance of robotic grasping. A specific case of study is reported as referring to LARM Hand IV, a three-fingered robotic hand which has been designed and built at LARM at the University of Cassino [14–17]. A dedicated test rig has been designed and set up to generate predefined voltage dips to experimentally investigate their effect on the grasping of objects with different sizes. Experimental tests are carefully analysed and discussed to demonstrate the influence of the voltage dips on the grasping performance, as well as to propose some mitigation actions to avoid safety implications during the grasping.

2. Main Characteristics of the Voltage Dips

The term PQ embraces a wide set of disturbances that can affect the voltage and/or current [3]. The disturbances are categorized in two groups: the variations and events [4]. Each group represents a different type of phenomena and different ways of treating the disturbances [5,6]. The variations and events are due to the interaction between the power supply and the devices installed at the customers’ premises.

Variations are minor changes from the ideal value of voltage or current that show a relatively slow reduction in value. The level of variations can be measured continuously and at predefined instants of time. Examples of variations are the voltage amplitude variations and the waveform distortion. Events can have large deviations from the ideal value and they can occur suddenly. Events cannot be measured continuously because they may occur occasionally. A trigger condition is needed to measure these events. In the group of events affecting the supply voltage, voltage dips are one of the most severe disturbances that can affect especially industrial end-users. Several devices are significantly vulnerable to voltage dips. The main detrimental effects of the voltage dips are the tripping of protected devices and the degradation of the performance of a device.

A voltage dip is defined as a “sudden reduction of the supply voltage, below 90% and above 1% of the declared voltage, followed by a voltage recovery after a short period of time” [4]. Figure 1 plots the time of a voltage affected by a dip. In Figure 1, the main characteristic quantities of a voltage dip are expressed as the amplitude with the symbol \( V_r \), and the duration with the symbol \( \Delta t \) as shown.
in Figure 1. The amplitude of a voltage dip is the minimum value of the RMS voltage during an event; it is known also as the residual voltage. The duration of a voltage dip is the time elapsed when the voltage falls below the threshold value, which is assumed to be 90% of the rated value. Further quantities can characterize a voltage dip, like the number of involved phases, the phase angle jump, or the symmetry of the voltage dips on the phases.

![Figure 1. Example of a real voltage dip in industrial frames [2].](image)

In transmission and distribution systems, most voltage dips originate with the short circuits and further causes include the start of a large motor and the insertion of a large transformer, or of a high power load as can frequently happen in industrial systems. In the transmission and distribution systems, the dips more frequently originate with short circuits in some nodes of the electrical network. In the presence of a symmetrical solid short circuit in a specific node, two main phenomena happen. In the node where the short circuit occurs, the voltage is equal to zero and in the other nodes electrically close to it, the voltage is affected by the sudden reduction that represents a voltage dip. This phenomenon lasts until the protection device clears the short circuit.

The framework of the actual standards on the limits of voltage dips is mainly referred to the IEC and the CENELEC norms. In particular, IEC 6100-4-11 [7] states the immunity test for the devices to define its operation class with reference to the EMC (Electro Magnetic Compatibility) and two main classes are defined which are the Class II and the Class III. The main standard of the CENELEC is the EN50160 that indicates the voltage characteristics of the electricity supply by public distribution network. In particular, for the voltage dips, this standard proposes the table shown in Table 1 to classify them according to residual voltage and duration.

Table 1 refers to all the voltage dips that can be recorded in a node. It allows for immediately ascertaining the performance of a node in a considered period, typically at least one year. Actually, the trends of future standardization activities on the voltage dips are towards a limitation of the number of voltage dips that can be tolerated at any node of a system in a defined time period as the year. The limits could be expressed using a table similar to that in Table 1. In such a case, any number of cells would express the boundary of the performance of the power supply that any customer should expect. Summarizing, the most important characteristics of a voltage dip are the amplitude and the duration.

<table>
<thead>
<tr>
<th>Residual Voltage $u$ [%]</th>
<th>$10 \leq t \leq 200$</th>
<th>$200 &lt; t \leq 500$</th>
<th>$500 &lt; t \leq 1000$</th>
<th>$1000 &lt; t \leq 5000$</th>
<th>$5000 &lt; t \leq 60,000$</th>
</tr>
</thead>
<tbody>
<tr>
<td>90 &gt; $u$ ≥ 80</td>
<td>A1</td>
<td>A2</td>
<td>A3</td>
<td>A4</td>
<td>A5</td>
</tr>
<tr>
<td>80 &gt; $u$ ≥ 70</td>
<td>B1</td>
<td>B2</td>
<td>B3</td>
<td>B4</td>
<td>B5</td>
</tr>
<tr>
<td>70 &gt; $u$ ≥ 40</td>
<td>C1</td>
<td>C2</td>
<td>C3</td>
<td>C4</td>
<td>C5</td>
</tr>
<tr>
<td>40 &gt; $u$ ≥ 5</td>
<td>D1</td>
<td>D2</td>
<td>D3</td>
<td>D4</td>
<td>D5</td>
</tr>
<tr>
<td>5 &gt; $u$</td>
<td>X1</td>
<td>X2</td>
<td>X3</td>
<td>X4</td>
<td>X5</td>
</tr>
</tbody>
</table>

Table 1. Classification of the voltage dips according to residual voltage and duration [EN50160].
3. Main Features of LARM Hand IV

Several designs have been developed for LARM Hand at LARM in Cassino, as detailed for example in [14–17]. The LARM Hand prototypes have three one-DOF (Degree of Freedom) human-like fingers. Their main features are low-cost design and easy operation. Only one motor is needed to drive each finger. Its torque is applied to the first link of its driving mechanism as indicated in Figure 2 with $C_m$. One of the most complex design issues for LARM Hand has been the design of a suitable driving mechanism that can be embedded in the finger body and remains within the finger body also during its movement, as shown in the scheme of Figure 2. This patented linkage-based driving mechanism of LARM Hand is described in full detail in references [14–17].

![Figure 2. A CAD model of LARM hand with its transmission mechanism and reactions in joints.](image)

The LARM Hand IV, shown in Figure 3, is equipped with three force sensors on each finger for measuring the grasping force on each phalanx while its operation is achieved by means of a low-cost PLC, which directly drives the three DC motors. A simple control logic is achieved by using a reference force threshold and by limiting the motor input current as it is directly linked with the motor output torque. It is worth noting that a firm grasp is achieved when all forces are in equilibrium. Therefore, the input torque has to be regulated to ensure a firm grasp as function of several parameters including the external force acting on the object, and the position, size, and shape of the grasped object. In this paper, we investigate how voltage dips influence the grasping of an object while using LARM Hand IV.

![Figure 3. A prototype of LARM Hand IV.](image)

4. Test Rig Set-Up

Experimental activities have been carried out to validate the effects of voltage dips by developing a dedicated test rig. The proposed test rig set up is outlined in Figure 4.

The main components of the proposed test rig are:

1. An AC Power Source model AMX 360 by Pacific Power Source Inc. (Irvine, CA, USA)
2. A dual stabilized Power Supply model 32DP32 by Elind (Milano, Italy);
3. A current sensor INA 219 by Texas Instruments (Dallas, TX, USA);
4. A LARM hand IV prototype, Figure 3;
5. An Arduino Mega board (Tilburg, the Netherlands);
6. A data acquisition board DAQ NI-6009 USB by National Instruments (Austin, TX, USA);
(7) A laptop with USB ports.

The voltage generation system is used to emulate the role of the electric network behavior. In fact, it can generate any predefined waveform. The voltage generation system is connected to a dedicated PC via GPIB. Its operation is managed by using a dedicated software called UPC Manager. This device is used to generate pre-defined voltage dips. The stabilized power supply that has been used is a high-performance power supply with fast recovery time and low current ripple. A Texas Instruments current sensor INA 219 has been selected for measuring the power supply to the LARM Hand. This has been selected due to its low cost and easy operation in combination with a cheap Arduino Mega board for data collection. Furthermore, the sensor resolution is suitable for the current absorbed by LARM Hand. Instead, a National Instruments DAQ NI-6009 USB has been used for collecting voltage outputs. This has been chosen for its convenient features in terms of cost, user-friendliness, and performance for the data acquisition of the analog data outputs generated by the four FSR piezo resistive force sensors that are on the LARM Hand.

![Figure 4. A scheme of the proposed test rig.](image)

5. The Proposed Testing Procedure

The built test rig is used to perform a set of experimental tests that have been selected for describing the most significant cases that can occur in the event of a voltage dip. For each test the LARM hand is set to start at an open position of the three fingers, and after about 5 s the LARM hand starts a phase with a closing operation of all fingers. This phase ends with the grasping of an object. As soon as contact is established between the object and fingers, the force sensors convert the grasping force into a voltage signal. The last phase consists of the opening of all fingers. Figure 5 shows a photo sequence of the testing phases where Figure 5a is the starting phase with fingers fully open; Figure 5b is showing the closing phase; Figure 5c shows the phase in which fingers are in contact with the object. The letters reported in Figure 6 and Table 2 summarize the effects on the most significant cases that can occur. Plots of the experimental tests are then reported for each case to demonstrate what is the corresponding effect on the grasping.

![Figure 5. A sequence of the operation phases of LARM Hand during testing: (a) starting phase with fingers fully open; (b) closing; (c) fingers in contact with the object.](image)
The tests that have been carried out can be divided into two main cases:

1. Absorbed current by LARM hand;
2. Tension output from the force sensor.

The tests that have been carried out can be divided into two main cases:
A. Normal condition with LARM hand being supplied by a nominal sinusoidal voltage without disturbances;
B. Voltage Dip condition with LARM hand being supplied by a sinusoidal voltage with voltage dips.

The type A case has been investigated to obtain the nominal performance of the LARM hand in order to have reference nominal output data. The type B cases aim to evaluate the effect of voltage dips on the grasping performance of LARM Hand. In particular, type B cases have been investigated by considering the voltage dip cases, which are reported in Table 2. Results of type A and type B cases are reported in the following section.

6. Testing Results

A first set of experimental results refers to the nominal performance of LARM hand as defined in the type A testing case in the previous section. In particular, it has been possible to collect the current absorbed by LARM Hand in nominal conditions as reported in the plot of Figure 7. Moreover, the output grasping force has been obtained as measured by the force sensors on each finger of LARM hand in nominal conditions as shown in Figure 8. The experimental data in Figures 7 and 8 are collected by using two different data acquisition boards, as shown in the scheme of Figure 4. The data sampling is synchronized using a common trigger while different sampling rates have been selected according to the different characteristics of the collected data.

Referring to Figure 7 it is possible to observe that in the first line segment the current value absorbed from the system has an average value of 750 mA. The current negative peak occurs in relation with the closing operation. This operation ends with a stabilized current value (660 mA) allowing a firm grasp. It is of note that a firm grasp is defined in terms of a static equilibrium of the grasped object with no relative motion with respect to the fingers in contact with the object. The time period is identified from the experimental data by identifying the grasping force changes and getting the corresponding time interval. From the collected data the closing operation lasts for 531 ms corresponding to the time needed to reach about 6 N from 0 N.

![Figure 7. Experimentally measured absorbed current by LARM hand in nominal conditions.](image1)

![Figure 8. Experimentally measured grasping forces in nominal conditions.](image2)
Moreover, Figure 8 shows that the measured grasping forces are all zero until the finger touch
the object during the grasping. Then, the grasping force quickly grows until a firm grasp is achieved.
At this time oscillations of the grasping force are measured due to small motions of the object as well
as due to small changes in the contact point between the object and the sensors as well as small joint
clearances on LARM Hand. Additionally, Figure 8 shows that the measured grasping forces on finger 2
and finger 3 are similar to each other while the grasping force on finger 1 is nearly twice as much as on
finger 2 or finger 3. This is due to the design of LARM hand where finger 1 is placed opposite to both
finger 2 and finger 3 so that it needs to apply twice as much force to balance the combined forces due
to finger 2 and finger 3.

The following set of experiments refer to cases a, b, and c in Table 2 where voltages dips with
residual tension of 70% have been considered. For these cases, any duration of the voltage dip did
not generate an appreciable variation on the grasping performance of LARM Hand. Given the similar
performance of cases a, b, and c in Table 2, only case c is reported here. This case refers to a voltage dip
with residual voltage of 70% and duration of 1000 ms. The measured plots for this case are reported in
Figures 9 and 10. In particular, Figure 9 shows a comparison of the current absorbed by LARM Hand
in nominal conditions and during a voltage dip of 70% and duration of 1000 ms. Figure 10 shows a
comparison of one of the measured grasping forces by LARM Hand in nominal conditions and during
a voltage dip of 70% with duration of 1000 ms. No significant differences can be identified in this case.

![Figure 9](image9.png)

**Figure 9.** Experimentally measured absorbed current with a voltage dip 70% with duration 1000 ms
(case c in Table 2).

![Figure 10](image10.png)

**Figure 10.** Comparison of the grasping force in normal conditions and voltage dip conditions 70% with
duration 1000 ms (case c in Table 2).

The tests with voltage dip with residual tension of 40% and duration of 100 ms (case d in Table 2)
have not shown any significant difference as compared with cases a, b, and c. Therefore, the related
plots have not been reported in this paper.

The next considered case refers to a voltage dip with residual tension of 40% and duration of
500 ms (case e in Table 2). In Figure 11 it is possible to note the effect that this type of voltage dip has
on the current absorbed by the LARM Hand. This result is even clearer in the zoomed view that is
shown in Figure 12, where the finger closing operation phase is shown. In particular, it is possible to identify in this plot a heavy ripple current. This ripple causes a significant degradation of the grasping performance, introducing a relevant delay in achieving the grasp. The produced grasping delay is longer than the duration of the voltage dip as the system takes some time to recover from the voltage dip and to go back to nominal operation conditions. The plot of the grasping force that is reported in Figure 13 shows clearly the effect of the measured current. In fact, the comparison between the measured forces with voltage dip and in nominal conditions shows a very significant change of the grasping force in terms of a step in the grasping force that significantly affects the achievement of a firm grasp. The first contact between the finger and the grasped object shows a similar value of grasping force, but after the voltage dip ends the system starts to get more current and this causes a grasping force increase on the object with the need of achieving a new grasping equilibrium condition and a higher risk of losing the firm grasp of the object, as indicated by the increase of the grasping force after the voltage dip.

**Figure 11.** Experimentally measured absorbed current with a voltage dip 40% with duration 500 ms (case e in Table 2).

**Figure 12.** A zoomed view of the absorbed current in Figure 11 with a voltage dip 40% with duration 500 ms (case e in Table 2) during the finger closing operation.

**Figure 13.** Comparison of the grasping force in normal conditions and voltage dip conditions 70% with duration 1000 ms (case e in Table 2).
The next considered case refers to a voltage dip with residual tension of 40% and duration of 1000 ms (case f in Table 2). In Figure 14 it is possible to note the effect that this type of voltage dip has on the current absorbed by the LARM Hand, which is similar to case e in Table 2. Figure 15 shows a zoomed view of Figure 14 by referring to the finger closing operation phase. In this plot there is a significant current ripple causing a significant degradation of the grasping performance and introducing a relevant delay in achieving the grasping. The produced grasping delay is significantly longer than the duration of the voltage dip, as the system takes some time to recover from the voltage dip and to go back to nominal operation conditions. The plot of the grasping force that is reported in Figure 16 shows clearly the effect of the measured current. In fact, the comparison between the measured forces with voltage dip and in nominal conditions shows a very significant change of the grasping force in terms of a step and a delay of about 140% in the grasping force. This effect significantly affects the achievement of a firm grasp although this is smoother than the previously analyzed case e in Table 2.

![Figure 14](image1.png)

**Figure 14.** Experimentally measured absorbed current with a voltage dip 40% with duration 1000 ms (case f in Table 2).

![Figure 15](image2.png)

**Figure 15.** A zoomed view of the absorbed current with a voltage dip 40% with duration 1000 ms (case f in Table 2) during the finger closing operation.

![Figure 16](image3.png)

**Figure 16.** Comparison of the grasping force in normal conditions and voltage dip conditions 70% with duration 1000 ms (case f in Table 2).
In the last case the voltage dip has such characteristics to fall fully below the vulnerability curve shown in Figure 6. This is the heaviest voltage dip in terms of residual voltage, which has been experimentally tested with residual voltage of 30% and duration 500 ms (case h in Table 2). The measured absorbed currents for this case are shown in Figure 17. This plot shows the current absorbed by the LARM Hand is drastically modified as compared with the nominal case. The reason is that this voltage dip causes the re-initialization of the system and the release of the grasped object with a complete manipulation failure.

![Figure 17. Experimentally measured absorbed current with a voltage dip conditions 30% with duration 500 ms (case h in Table 2); in this case, the LARM Hand fully turns off and re-initializes after the voltage dip.](image)

Results of the reported experimental tests prove the significant influence of voltage dips on the grasping performance. In particular, tests have identified four main cases:

- **Voltage dips above the vulnerability curve, Figure 6,** (residual tension between 90% and 70% of the nominal value and duration under 500 ms): They do not generate any significant degradation of the performance.

- **Voltage dips below the vulnerability curve, Figure 6,** (residual tension below 40% of the nominal value and duration above 400 ms): They generate a quite significant performance degradation with a temporary complete system shut down. This case is the most undesired one as the grasping/manipulation process is stopped with potential economic implications in an industrial production as well as potential safety implications if the grasping is performed during human-robot collaborative tasks.

- **Voltage dips close to the vulnerability curve shown in Figure 6,** (cases between the previous ones): In these cases, there is a progressive degradation of performances. The most evident effect is current ripple and a delay in current supply that is amplified in terms of evident delays and steps in the grasping forces that significantly affect the firm grasping as well as that can produce damages on grasped objects due to unexpected overloadings.

- **With voltage dip with 40% of residual voltage and duration of 500 ms cause a delay of the closing operation,** which goes from the initial 531 ms in normal conditions to 700 ms, the closing time increasing by 40%. Even the absorbed current is affected by a big variation the maximum difference from the one in normal condition and the one in presence of voltage dip is 500 mA. Further, the grasping force suffers from sudden step variations in magnitude that can cause significant problems, especially while grasping very delicate objects.

The investigated operation of LARM hand can be considered as a case study offering some general rules. In particular, this gives insight on the significance and potential usage of the vulnerability curve for predicting and addressing the behavior of any robotic grasping device with respect to power quality.
7. Conclusions

This paper is focused on offering an evaluation of the effects of voltage dips on robot operation by looking at a case study a prototype LARM hand. The main characteristics of electric supply failures are addressed to outline both the occurrences and effects on a robotic system. The specific analysis and testing on grasping by the LARM hand shows that electric voltage dips can significantly affect the robotic operation. A specific vulnerability curve has been identified to predict the effects on the robot operation that are produced by the electric power supply input in terms of duration and magnitude of a voltage dip.

Author Contributions: Conceptualization, M.C., G.C., P.V. (Pietro Varilone) and P.V. (Paola Verde); methodology, M.C., G.C., P.V. (Pietro Varilone) and P.V. (Paola Verde); validation, C.F., and G.C.; writing—original draft preparation, G.C. and C.F.; writing—review and editing, G.C., M.C., P.V. (Pietro Varilone) and P.V. (Paola Verde)

Funding: This project received no specific funding.

Conflicts of Interest: Authors declare no conflict of interest.

References


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